



RADIO TEST REPORT

Test Report No. : 28CE0018-HO-01-A-R1

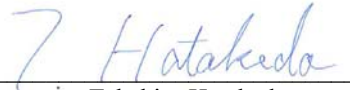
Applicant : Sony Corporation
Type of Equipment : Wireless transceiver
Model No. : EZW-RT10
FCC ID : AK8A1368101A
Test standard : FCC Part 15 Subpart C 2007
Section 15.207, Section 15.247
Test Result : Complied

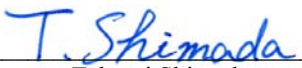
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2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with the above regulation.
4. The test results in this report are traceable to the national or international standards.
5. Original test report number of this report is 28CE0018-HO-01-A.

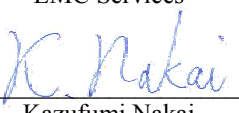
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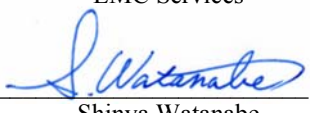
December 18 to 26, 2007

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SECTION 1: Customer information

Company Name : Sony EMCS Corporation Kisarazu TEC
Address : 8-4 Shiomi Kisarazu-shi, Chiba 292-0834 Japan
Telephone Number : +81-438-37-3982
Facsimile Number : +81-438-37-4705
Contact Person : Kazuhiko Nagano

*Sony EMCS Corporation Kisarazu TEC is on behalf of the applicant: Sony Corporation.

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : Wireless transceiver
Model No. : EZW-RT10
Serial No. : 2 (Used for Antenna terminal conducted test)
3 (Used for all other tests)
Rating : 3.3V
Country of Manufacture : China
Receipt Date of Sample : November 12, 2007
Condition of EUT : Engineering prototype
(Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT : No modification by the test lab.

2.2 Product Description

Model No: EZW-RT10 (referred to as the EUT in this report) is the Wireless transceiver.

Feature of EUT : Digital Wireless Audio Transceiver adapter

The EUT has three channels, 2411.85MHz, 2437.85MHz and 2463.85MHz.

EUT Clock	RF IC: 22MHz	
Equipment Type	Transceiver	
Frequency of Operation	2411.85MHz to 2463.85MHz	
Type of Modulation	DSSS	
Method of Frequency Generation	Crystal	
Bandwidth	22MHz	
Power Supply (inner)	DC3.3V	
Antenna Type	ANT: A: Pattern Antenna	ANT: B: Pattern Antenna
Antenna Gain	ANT: A: 2.1dBi	ANT: B: 2.1dBi

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification	:	FCC Part15 Subpart C: 2007
Title	:	FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators Section 15.207 Conducted limits Section 15.247 Operation within the bands 902-928MHz, 2400-2483.5MHz, and 5725-5850MHz

FCC 15.31 (e)

The host device provides stable voltage (DC3.3V) constantly to the EUT. Therefore, this EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is pattern antenna. Therefore, the equipment complies with the antenna requirement of Section 15.203.

3.2 Procedures and results

[DSSS and other forms of modulation]

No.	Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results
1	Conducted emission	FCC: ANSI C63.4:2003 7. AC powerline conducted emission measurements IC: RSS-Gen 7.2.2	FCC: Section 15.207 IC: RSS-Gen 7.2.2	-	N/A	QP 12.9dB 0.19161MHz, N ANT: A, Tx, Ch: Low AV 6.3dB 0.19161MHz, N ANT: A, Tx, Ch: Low	Complied
2	6dB Bandwidth	FCC: "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247" IC: RSS-Gen 4.6.2	FCC: Section 15.247(a)(2) IC: RSS-210 A8.2(a)	Conducted	N/A	See data.	Complied
3	Maximum Peak Output Power	FCC: "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247" IC: RSS-Gen 4.8	FCC: Section 15.247(b)(3) IC: RSS-210 A8.4(4)	Conducted	N/A		Complied
4	Restricted Band Edges	FCC: "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247" IC: -	FCC: Section 15.247 (d) IC: RSS-210 A8.5	Conducted/ Radiated	N/A		Complied
5	Power Density	FCC: "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247" IC: -	FCC: Section 15.247 (e) IC: RSS-210 A8.2(b)	Conducted	N/A		Complied
6	Spurious Emission	FCC: "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247" IC: RSS-Gen 4.9 RSS-Gen 4.10	FCC: Section15.247(d) IC: RSS-210 A8.5 RSS-Gen 7.2.1 and 7.2.3	Conducted/ Radiated	N/A	[Tx] 0.4dB 2483.5MHz, Horizontal, PK ANT: A, Ch: High [Rx] 4.5dB 6500.8MHz, Horizontal, AV ANT: A, Ch: Mid 6500.9MHz, Horizontal, AV ANT: B, Ch: Mid	Complied

Note: UL Japan, Inc.'s EMI Work Procedures No.QPM05 and QPM15.

*These tests were performed without any deviations from test procedure except for additions or exclusions.

3.3 Addition to standards

No.	Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results
1	99% Occupied Band Width	IC: RSS-Gen 4.6.1	IC: RSS-Gen 4.6.1	Conducted	N/A	N/A	N/A

3.4 Uncertainty

EMI

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Test room	Conducted emission	Radiated emission (10m*)				Radiated emission (3m*)			Radiated emission (3m*)	
	150kHz-30MHz	9kHz-30MHz	30MHz-300MHz	300MHz-1GHz	9kHz-30MHz	30MHz-300MHz	300MHz-1GHz	1GHz-18GHz	18GHz-40GHz	
No.1 semi-anechoic chamber	±3.7dB	±3.1dB	±4.7dB	±4.4dB	±3.2dB	±3.7dB	±4.4dB	±5.9dB	±6.1dB	
No.2 semi-anechoic chamber	±3.7dB	-	-	-	±3.2dB	±4.3dB	±3.9dB	±5.9dB	±6.1dB	
No.3 semi-anechoic chamber	±3.7dB	-	-	-	±3.2dB	±4.2dB	±4.4dB	±5.9dB	±6.1dB	
No.4 semi-anechoic chamber	±3.7dB	-	-	-	±3.2dB	±4.2dB	±4.4dB	±5.9dB	±6.1dB	

*10m/3m = Measurement distance

Conducted emission test

The data listed in this test report has enough margin, more than the site margin.

Radiated emission test(3m)

The data listed in this report meets the limits unless the uncertainty is taken into consideration.

Other test except Conducted Emission and Spurious Emission (Radiated)

The measurement uncertainty for this test is ±3.0dB.

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3.5 Test Location

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	FCC Registration Number	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	313583	IC4247	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	655103	IC4247-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	148738	IC4247-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	134570	IC4247-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	-	4.0 x 4.5 x 2.7m	4.75 x 5.4 m	-
No.6 measurement room	-	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	-	8.0 x 4.5 x 2.8m	2.0 x 2.0m	-
No.10 measurement room	-	-	2.6 x 2.8 x 2.5m	2.4 x 2.4m	-
No.11 measurement room	-	-	3.1 x 3.4 x 3.0m	2.4 x 3.4m	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test set up, Test instruments and Data of EMI

Refer to APPENDIX 1 to 3.

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SECTION 4: Operation of E.U.T. during testing

4.1 Operating Mode(s)

The mode used for test :

Test	Mode	Tested frequency	Tested antenna
Conducted emission Spurious Emission (Radiated)	Transmitting (Tx)	2411.85MHz 2437.85MHz 2463.85MHz	ANT: A ANT: B
	Receiving (Rx)	2437.85MHz	ANT: A ANT: B
6dB Bandwidth 99% Occupied Bandwidth	Transmitting (Tx)	2411.85MHz 2437.85MHz 2463.85MHz	ANT: A
Power Density	Transmitting (Tx)	2413.23MHz 2436.94MHz 2462.51MHz	ANT: A
Maximum Peak Output Power	Transmitting (Tx)	2411.85MHz 2437.85MHz 2463.85MHz	ANT: A ANT: B
Spurious Emission (Conducted)	Transmitting (Tx)	2411.85MHz 2437.85MHz 2463.85MHz	ANT: A
	Receiving (Rx)	2437.85MHz	ANT: A

*As a result of preliminary check for two antennas (ANT: A and ANT: B), the formal test was performed as above-mentioned table.

Preliminary check result (Worst antenna):

Antenna Terminal Conducted test : ANT: A

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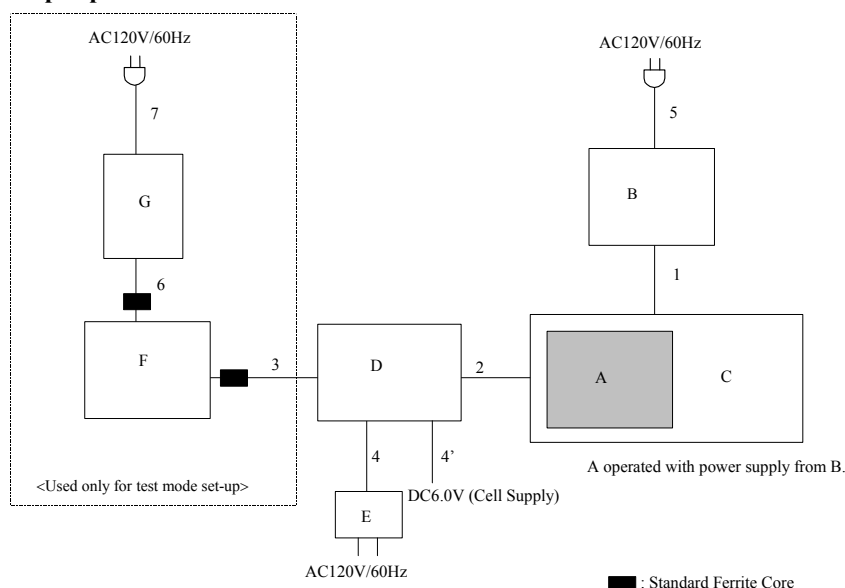
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4.2 Configuration and peripherals



* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

Description of EUT and Support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Wireless transceiver	EZW-RT10	2 *1) 3 *2)	SONY	EUT
B	Surround Amplifier	TA-SA100WR	-	SONY	Host device
C	IF Board	-	D02	SONY	-
D	EVK Board	-	125	WSS	-
E	AC Adaptor	US118-0526	705-0802283	BUFFALO	*2)
F	Note PC	PCG-4A1N	281654101401044	SONY	-
G	AC Adaptor	PCGA-AC16V6	1477749521189378	SONY	-

*1) Used for Antenna terminal conducted test.

*2) Used for all other tests.

List of cables used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	DC Cable	1.7	Unshielded	Unshielded	-
2	Signal Cable	0.3	Unshielded	Unshielded	-
3	USB Cable	1.2	Shielded	Shielded	-
4	DC Cable	1.8	Unshielded	Unshielded	*1)
4'	DC Cable	0.1	Unshielded	Unshielded	*2)
5	AC Cable	1.8	Unshielded	Unshielded	-
6	DC Cable	1.8	Unshielded	Unshielded	-
7	Signal Cable	0.8	Unshielded	Unshielded	-

*1) Used for Antenna terminal conducted test.

*2) Used for all other tests.

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SECTION 5: Conducted Emission

Test Procedure and conditions

EUT was placed on a urethane platform of nominal size, 1m by 1.5m, raised 80cm above the conducting ground plane. The rear of tabletop was located 40cm to the vertical conducting plane. The rear of EUT, including peripherals aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80cm from a Line Impedance Stabilization Network (LISN)/ Artificial mains Network (AMN) and excess AC cable was bundled in center.

For the tests on EUT with other peripherals (as a whole system)

I/O cable and AC cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30cm to 40cm long and were hanged at a 40cm height to the ground plane. All unused 50ohm connectors of the LISN(AMN) were resistivity terminated in 50ohm when not connected to the measuring equipment.

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT in a Semi Anechoic Chamber or a Measurement Room.

The EUT was connected to a LISN (AMN).

An overview sweep with peak detection has been performed.

Detector	: quasi-peak and average detector (IF BW 9 kHz)
Measurement range	: 0.15-30MHz
Test data	: APPENDIX 2
Test result	: Pass

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SECTION 6: Spurious Emission

[Conducted]

Test Procedure

The Out of Band Emission was measured with a spectrum analyzer connected to the antenna port.
The following spectrum analyzer setting was used:

- RBW: 100kHz
- VBW: 300kHz
- Sweep: Auto
- Detector: Peak
- Trace: Max Hold

Test data : APPENDIX 2

Test result : Pass

[Radiated]

Test Procedure

EUT was placed on a urethane platform of nominal size, 0.5m by 1.5m, raised 80cm above the conducting ground plane. The Radiated Electric Field Strength intensity has been measured in a Semi Anechoic Chamber with a ground plane and at a distance of 3m(Below 10GHz) and 1m(Upper 10GHz).

The height of the measuring varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer (in linear mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

In any 100kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator confirmed 20dB below that in the 100kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement.

20dBc was applied to the frequency over the limit of FCC 15.209 / Table 2 of RSS-210 2.7 (IC) and outside the restricted band of FCC15.205 / Table 1 of RSS-210 2.7 (IC).

Frequency	Below 1GHz	Above 1GHz
Instrument used	Test Receiver / Spectrum Analyzer	Spectrum Analyzer
Detector	QP: BW 120kHz(T/R)	PK: RBW:1MHz/VBW: 1MHz
IF Bandwidth	20dBc : RBW: 100kHz VBW: 300kHz (S/A)	AV: RBW:1MHz/VBW:10Hz or RBW:1MHz/VBW:430Hz *1) 20dBc : RBW:100kHz/VBW:300kHz

*1) Used for the band edge of the carrier and the harmonics that can be measured. The VBW is based on the inverse of the duty cycle (see page 43).

- The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT's antenna to see the position of maximum noise, and the test was made at the position that has the maximum noise.

Test data : APPENDIX 2

Test result : Pass

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SECTION 7: Bandwidth

Test Procedure

The bandwidth was measured with a spectrum analyzer connected to the antenna port.
The following spectrum analyzer setting was used:

- Span: 50MHz
- RBW: 100kHz
- VBW: 300kHz
- Sweep: Auto
- Detector: Peak
- Trace: Max Hold

Test data	: APPENDIX 2
Test result	: Pass

SECTION 8: Maximum Peak Output Power

Test Procedure

The Maximum Peak Output Power was measured with a power meter (tested bandwidth: 50MHz) connected to the antenna port.
It was measured based on "Power Output Option 1" of "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247".

Test data	: APPENDIX 2
Test result	: Pass

SECTION 9: Peak Power Density

[Conducted]

Test Procedure

The Peak Power Density was measured with a spectrum analyzer connected to the antenna port.
It was measured based on "PSD Option 1" of "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247".

- Span: 1.5MHz
- RBW: 3kHz
- VBW: 100kHz
- Sweep: 500sec.
- Detector: Peak
- Trace: Single Clear

Test data	: APPENDIX 2
Test result	: Pass

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